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**INFORMATION
DISCLOSURE STATEMENT**

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Attorney Docket	AERX-071CIP
First Named Inventor	SCHUSTER, JEFFREY A.
Application Number	10/642,436
Confirmation No.	9902
Filing Date	August 14, 2003
Group Art Unit	3761
Examiner Name	
Title:	"METHOD AND DEVICE FOR NON-DESTRUCTIVE ANALYSIS OF PERFORATIONS IN A MATERIAL"

Sir:

This is an Information Disclosure Statement submitted for the Examiner's consideration. A Form PTO-SB/08A listing the references and copies of the cited references accompany this paper. Applicants would appreciate the Examiner's initialing and returning the form to indicate that the references have been reviewed and made of record.

All of the references identified herein were disclosed in parent application serial number 09/330,254, filed 6/10/1999 and as such, copies thereof are not included pursuant to the provisions of 37 CFR § 1.98(d).

This Information Disclosure Statement is not intended as a representation that a search has been made, that additional information material to the examination of this application does not exist, or that any one of the above references constitutes prior art to the present application within the meaning of 35 U.S.C. § 102.

As applicants have not yet received a first Action on the merits, no fee is believed to be required for filing this Disclosure Statement. If, however, the PTO finds that for some reason a fee is due, our Deposit Account No. 50-0815, Order No. AERX-071CIP may be charged thereon.

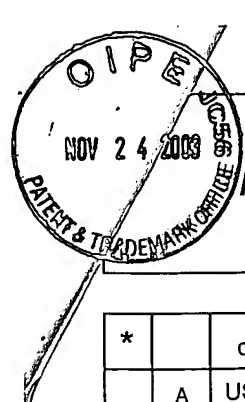
Respectfully submitted,
BOZICEVIC, FIELD & FRANCIS LLP

Date: 11/24/03

By: 

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Notice of References Cited

Application/Control No. 09/330,254		Applicant(s)/Patent Under Reexamination PON ET AL.	
Examiner Michael P. Stafira		Art Unit 2877	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,441,340 a1	08-2002	Varriano-Marston, Elizabeth	219/121.7
	B	US-6,140,604 a1	10-2000	Somers et al.	219/121.71
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
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	J	US-			
	K	US-			
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FOREIGN PATENT DOCUMENTS

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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.



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Examiner Michael P. Stafira		Art Unit 2877	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number	Date	Name	Classification ²	
		Country Code-Number-Kind Code	MM-YYYY ¹			
x	A	5,745,168	4/1998	Ninomiya	348	191
x	B	4,647,208	3/1987	Bieman	356	375
x	C	4,596,037	6/1986	Bouchard et al.	382	8
x	D	3,806,252	4/1974	Harris et al.	356	156
	E	3,711,205	1/1973	Tulk et al.	356	162
	F	4,930,889	6/1990	Van Donselaar et al.	356	237
	G	5,528,359	6/1996	Taguchi	356	237
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A	5,745,168	4/1998	Ninomiya	348	191
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INFORMATION DISCLOSURE CITATION

Form PTO-1449 (Modified)

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ATTY. DOCKET NO.

AERX-030

SERIAL NO.

09/330,254

APPLICANT

Pon, et al.

FILING DATE

June 10, 1999

GROUP

3761

U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA-1	5,497,764	03-12-96	Ritson, et al.	128	200.14	03-09-95
	AB-1	5,544,646	08-13-96	Lloyd, et al.	128	200.14	05-20-94
	AC-1	5,660,166	08-26-97	Lloyd, et al.	128	200.14	04-10-96
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	AE-1	5,718,222	02-17-98	Lloyd, et al.	128	200.14	05-30-95
	AF-1	5,823,178	10-20-98	Lloyd, et al.	128	200.14	08-02-96
	AG-1	5,829,435	11-03-98	Rubsamen, et al.	128	203.21	02-24-97

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.